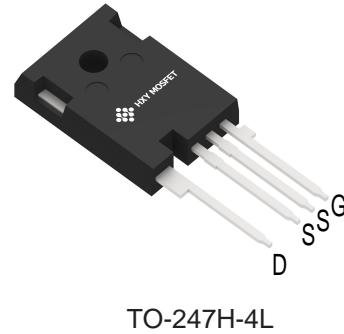




## Features

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery ( $Q_{rr}$ )
- Halogen free, RoHS compliant



## Benefits

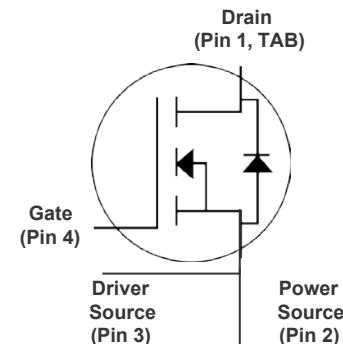
- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

## Applications

- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies



Ordering Part Number	Package	Qty(PCS)
CRXQF40M120G2Z	TO-247H-4L	30



## Maximum Ratings ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions
$V_{DS\max}$	Drain - Source Voltage	1200	V	$V_{GS} = 0 \text{ V}$ , $I_D = 100 \mu\text{A}$
$V_{GS\max}$	Gate - Source Voltage (dynamic)	-10/+25	V	AC ( $f > 1 \text{ Hz}$ )
$V_{GSop}$	Gate - Source Voltage (static)	-5/+20	V	Static
$I_D$	Continuous Drain Current	78	A	$V_{GS} = 15 \text{ V}$ , $T_c = 25^\circ\text{C}$
		57		$V_{GS} = 15 \text{ V}$ , $T_c = 100^\circ\text{C}$
$I_{D(pulse)}$	Pulsed Drain Current	TBD	A	Pulse width $t_p$ limited by $T_{J\max}$
$P_D$	Power Dissipation	405	W	$T_c = 25^\circ\text{C}$ , $T_j = 175^\circ\text{C}$
$T_j$ , $T_{stg}$	Operating Junction and Storage Temperature	-40 to +175	°C	
$T_L$	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s



**Electrical Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			V	$V_{GS} = 0 \text{ V}$ , $I_D = 100 \mu\text{A}$	Fig. 11
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	2.5	4.0	V	$V_{DS} = V_{GS}$ , $I_D = 10 \text{ mA}$	
			1.5		V	$V_{DS} = V_{GS}$ , $I_D = 10 \text{ mA}$ , $T_J = 175^\circ\text{C}$	
$I_{DSS}$	Zero Gate Voltage Drain Current		1	50	$\mu\text{A}$	$V_{DS} = 1200 \text{ V}$ , $V_{GS} = 0 \text{ V}$	
$I_{GSS}$	Gate-Source Leakage Current		10	200	$\text{nA}$	$V_{GS} = 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$	
		-200	-10		$\text{nA}$	$V_{GS} = -10 \text{ V}$ , $V_{DS} = 0 \text{ V}$	
$R_{DS(\text{on})}$	Drain-Source On-State Resistance		40	50	$\text{m}\Omega$	$V_{GS} = 20 \text{ V}$ , $I_D = 40 \text{ A}$	Fig. 4, 5, 6
			59			$V_{GS} = 20 \text{ V}$ , $I_D = 40 \text{ A}$ , $T_J = 175^\circ\text{C}$	
$g_{fs}$	Transconductance		10.4		S	$V_{DS} = 20 \text{ V}$ , $I_{DS} = 40 \text{ A}$	Fig. 7
			7.7			$V_{DS} = 20 \text{ V}$ , $I_{DS} = 40 \text{ A}$ , $T_J = 175^\circ\text{C}$	
$C_{iss}$	Input Capacitance		2101		pF	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 1000 \text{ V}$ $f = 100 \text{ kHz}$ $V_{AC} = 25 \text{ mV}$	Fig. 17, 18
$C_{oss}$	Output Capacitance		161				
$C_{rss}$	Reverse Transfer Capacitance		14				
$E_{oss}$	$C_{oss}$ Stored Energy		90		$\mu\text{J}$	$V_{DS} = 800 \text{ V}$ , $V_{GS} = -5 \text{ V}/+20 \text{ V}$ , $I_D = 40 \text{ A}$ , $R_{G(\text{ext})} = 2.5 \Omega$ , $L = 100 \mu\text{H}$ , $T_J = 175^\circ\text{C}$	Fig. 16
$E_{ON}$	Turn-On Switching Energy (SiC Diode FWD)		1100		$\mu\text{J}$		
$E_{OFF}$	Turn Off Switching Energy (SiC Diode FWD)		900		$\mu\text{J}$		
$t_{d(on)}$	Turn-On Delay Time		22		ns	$V_{DD} = 800 \text{ V}$ , $V_{GS} = -5 \text{ V}/20 \text{ V}$ $R_{G(\text{ext})} = 2.5 \Omega$ , $I_D = 40 \text{ A}$ Timing relative to $V_{DS}$	Fig. 27
$t_r$	Rise Time		49				
$t_{d(off)}$	Turn-Off Delay Time		71				
$t_f$	Fall Time		23				
$R_{G(\text{int})}$	Internal Gate Resistance		1.7		$\Omega$	$f = 1 \text{ MHz}$ , $V_{AC} = 25 \text{ mV}$	
$Q_{gs}$	Gate to Source Charge		33		nC	$V_{DS} = 800 \text{ V}$ , $V_{GS} = -5 \text{ V}/20 \text{ V}$ $I_D = 40 \text{ A}$	Fig. 12
$Q_{gd}$	Gate to Drain Charge		51				
$Q_g$	Total Gate Charge		131				

**Reverse Diode Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions		Note
$V_{SD}$	Diode Forward Voltage	4.1		V	$V_{GS} = -5 \text{ V}$ , $I_{SD} = 20 \text{ A}$ , $T_J = 25^\circ\text{C}$		Fig. 8, 9, 10
		3.5		V	$V_{GS} = -5 \text{ V}$ , $I_{SD} = 20 \text{ A}$ , $T_J = 175^\circ\text{C}$		
$I_s$	Continuous Diode Forward Current		83	A	$V_{GS} = -4 \text{ V}$ , $T_c = 25^\circ\text{C}$		Note 1
$I_{s, \text{pulse}}$	Diode pulse Current		TBD	A	$V_{GS} = -4 \text{ V}$ , pulse width $t_p$ limited by $T_{j\text{max}}$		Note 1
$t_{rr}$	Reverse Recover time	56		ns	$V_{GS} = -5 \text{ V}$ , $I_{SD} = 40 \text{ A}$ , $V_R = 800 \text{ V}$ $di/dt = 2250 \text{ A}/\mu\text{s}$ , $T_J = 175^\circ\text{C}$		Note 1
$Q_{rr}$	Reverse Recovery Charge	508		nC			
$I_{rrm}$	Peak Reverse Recovery Current	18		A			

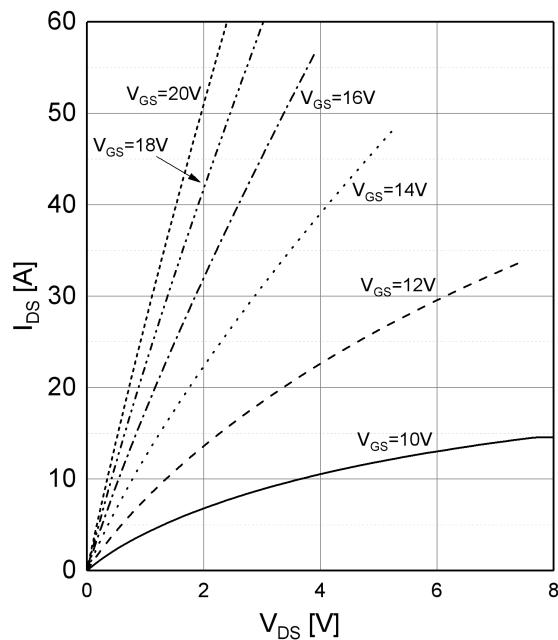
**Thermal Characteristics**

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.25	°C/W		Fig. 21
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient	40			

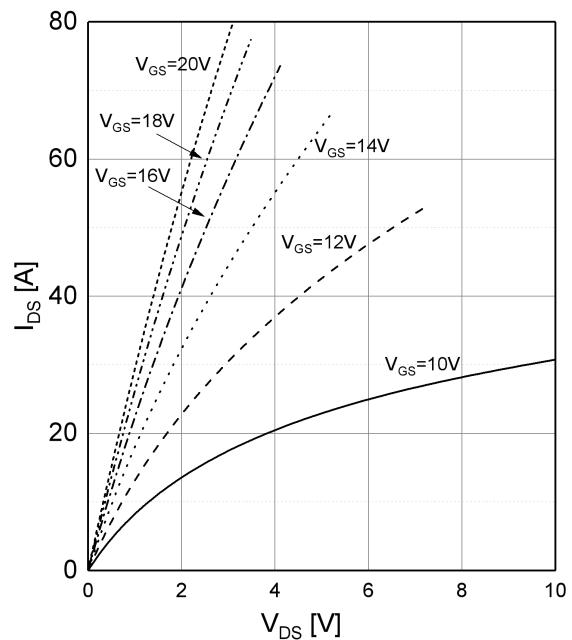


## Typical Characteristics

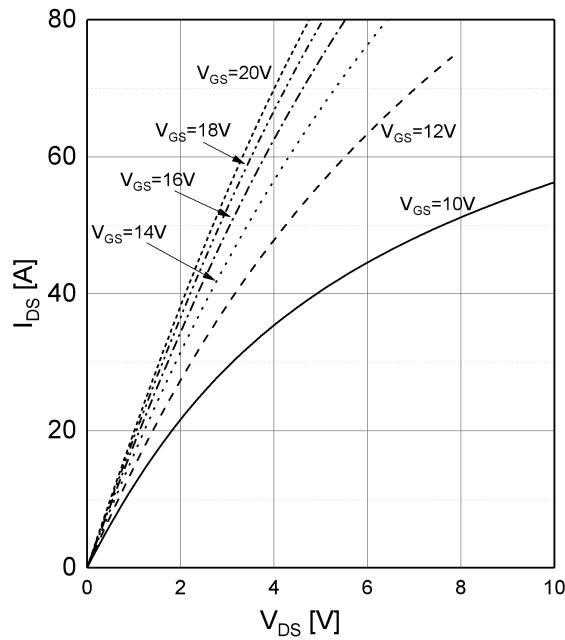
Output characteristics  
 $I_{DS} = f(V_{DS})$ ,  $T_J = -55^\circ\text{C}$



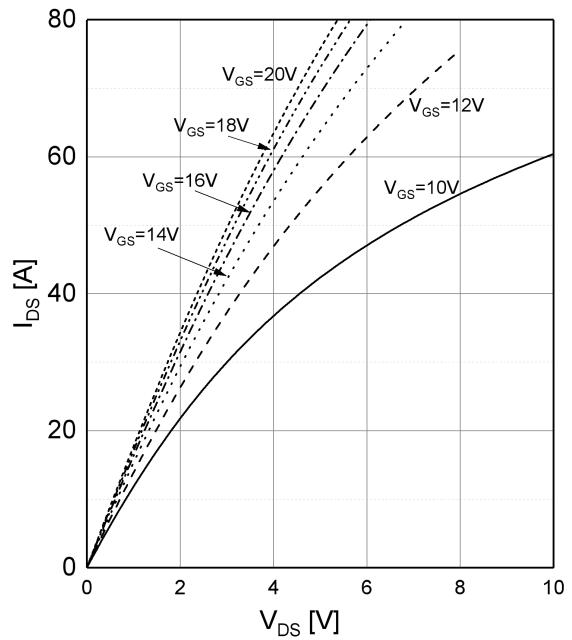
Output characteristics  
 $I_{DS} = f(V_{DS})$ ,  $T_J = 25^\circ\text{C}$



Output characteristics  
 $I_{DS} = f(V_{DS})$ ,  $T_J = 150^\circ\text{C}$



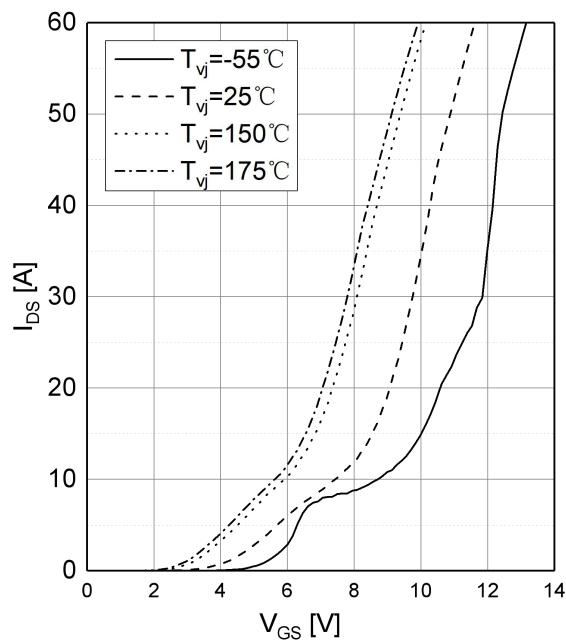
Output characteristics  
 $I_{DS} = f(V_{DS})$ ,  $T_J = 175^\circ\text{C}$





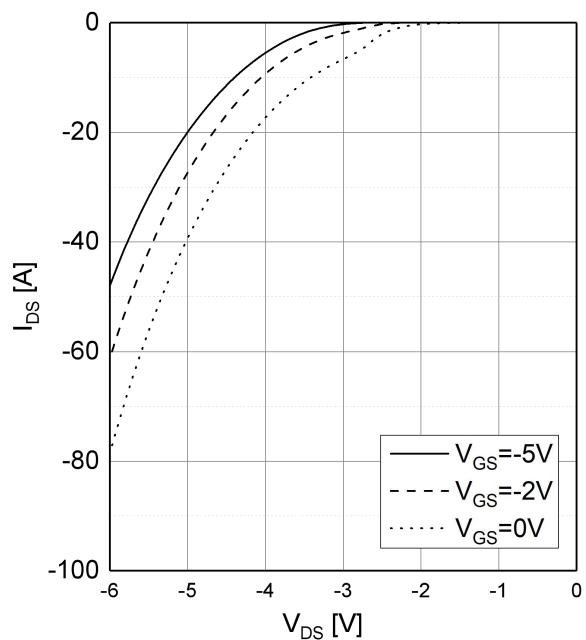
Transfer Characteristics

$I_{DS} = f(V_{GS})$ ,  $V_{DS} = 20V$



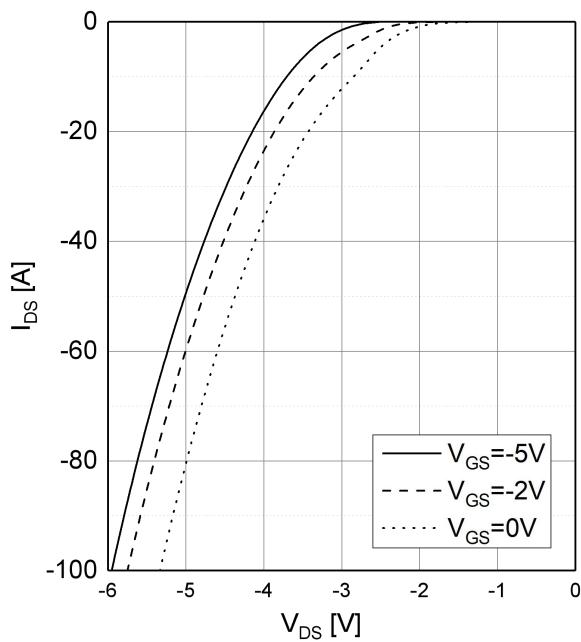
Body Diode Characteristics

$I_{DS} = f(V_{DS})$ ,  $T_j = -55^\circ\text{C}$



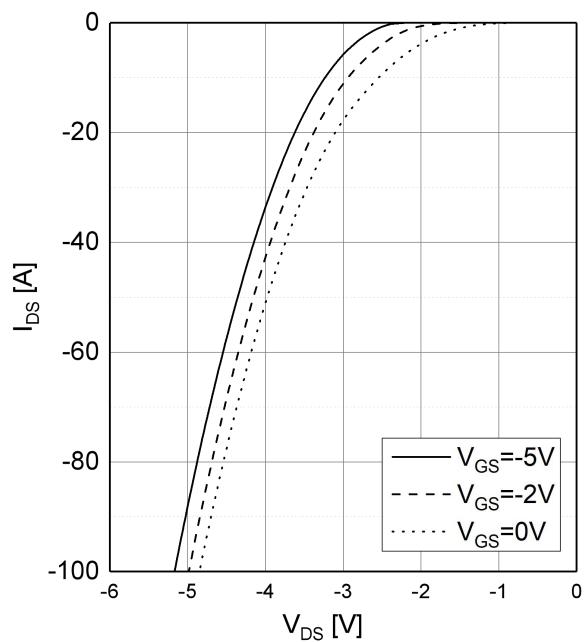
Body Diode Characteristics

$I_{DS} = f(V_{DS})$ ,  $T_j = 25^\circ\text{C}$



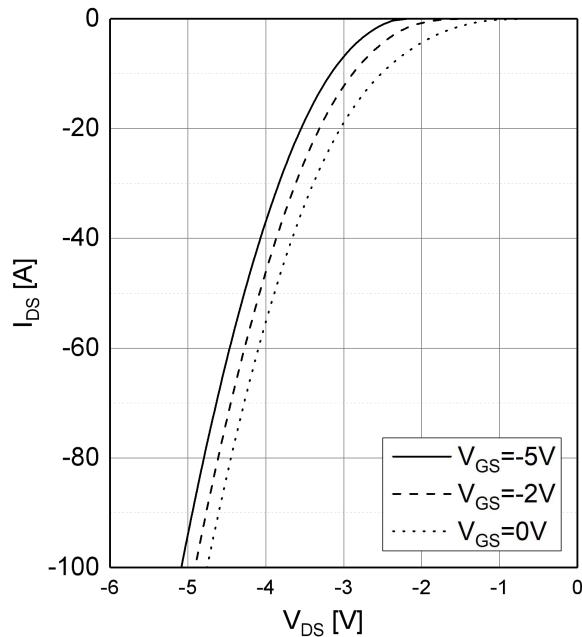
Body Diode Characteristics

$I_{DS} = f(V_{DS})$ ,  $T_j = 150^\circ\text{C}$

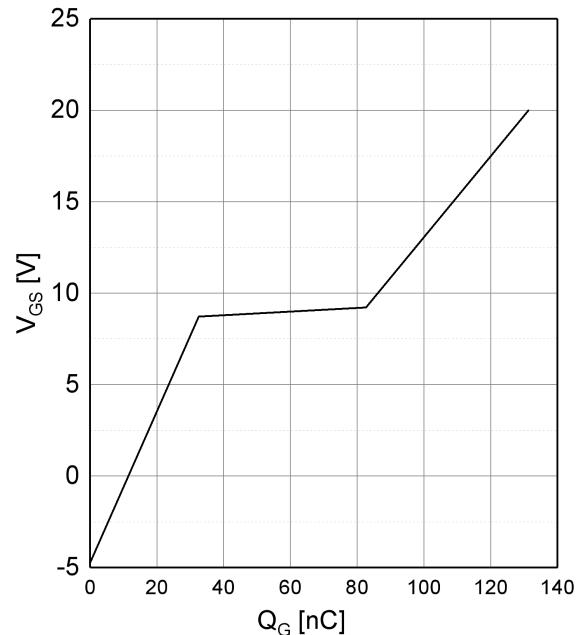




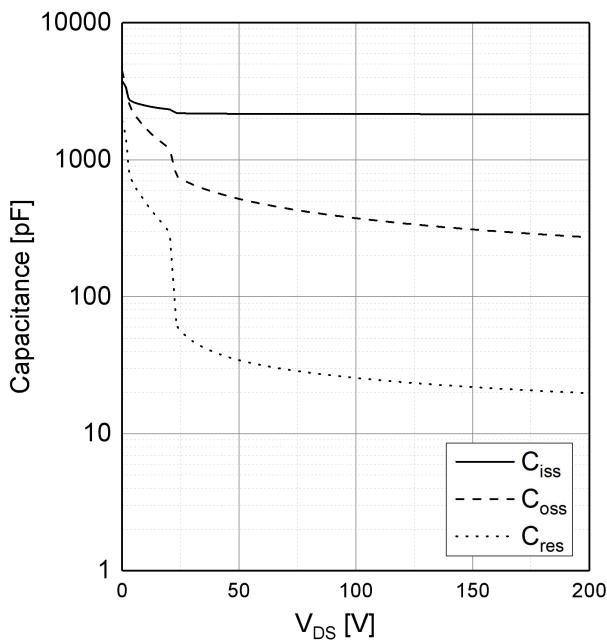
**Body Diode Characteristics**  
 $I_{DS} = f(V_{DS})$ ,  $T_J = 175^\circ C$



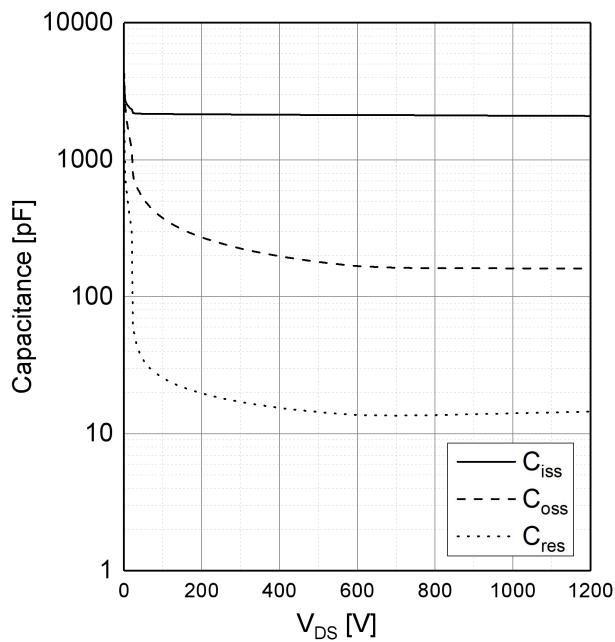
**Gate Charge Characteristics**  
 $V_{GS} = f(Q_G)$ ,  $I_{DS} = 40A$ ,  $V_{DS} = 800V$ ,  $T_J = 25^\circ C$



**Capacitances vs Drain-Source Voltage (0-200V)**  
 $C = f(V_{DS})$ ,  $T_J = 25^\circ C$ ,  $V_{AC} = 25mV$ ,  $f = 100KHz$

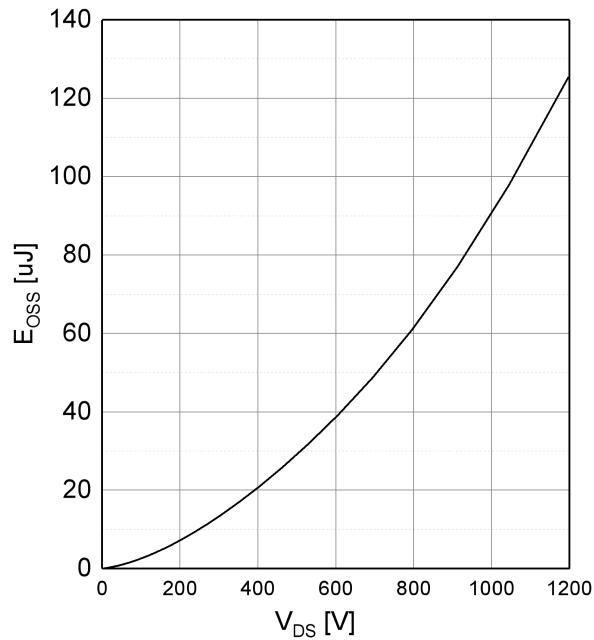


**Capacitances vs Drain-Source Voltage (0-1200V)**  
 $C = f(V_{DS})$ ,  $T_J = 25^\circ C$ ,  $V_{AC} = 25mV$ ,  $f = 100KHz$

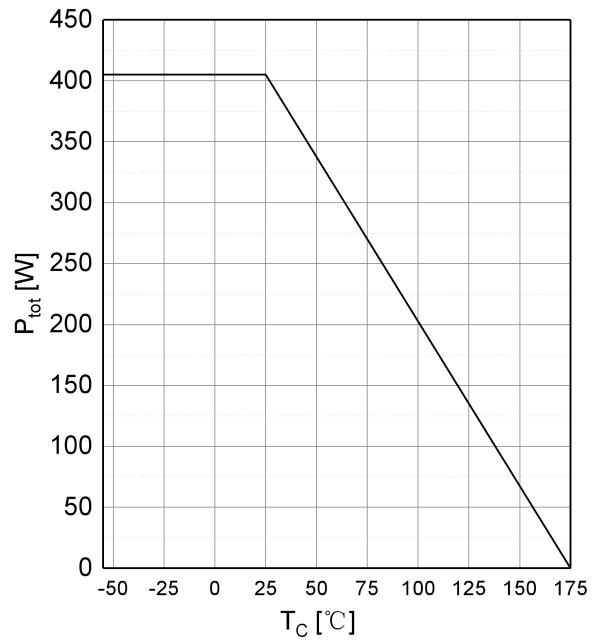




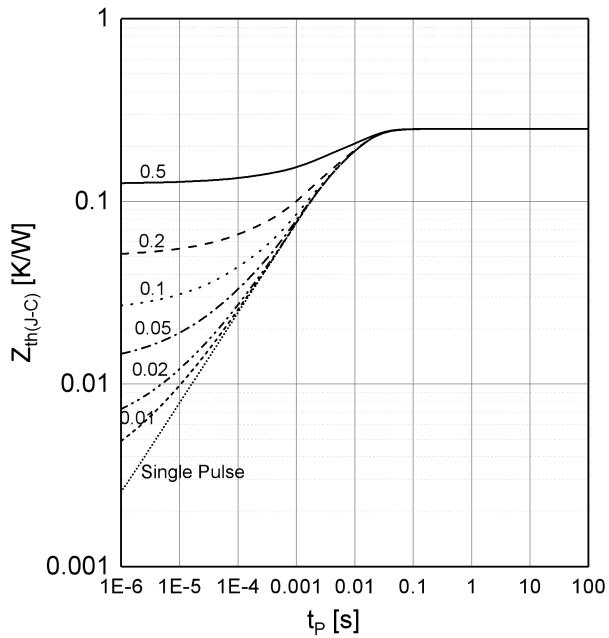
**Output Capacitor Stored Energy**  
 $E_{OSS} = f(V_{DS})$ ,  $T_J = 25^\circ\text{C}$



**Maximum Power Dissipation Derating**  
 $P_{tot} = f(T_c)$ ,  $T_J \leq 175^\circ\text{C}$



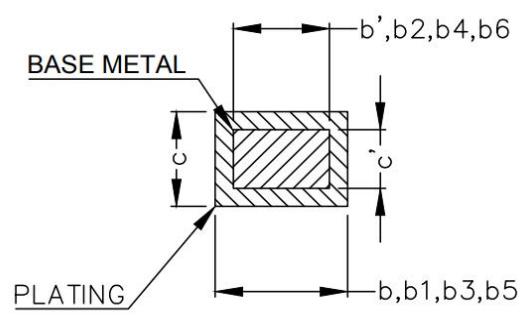
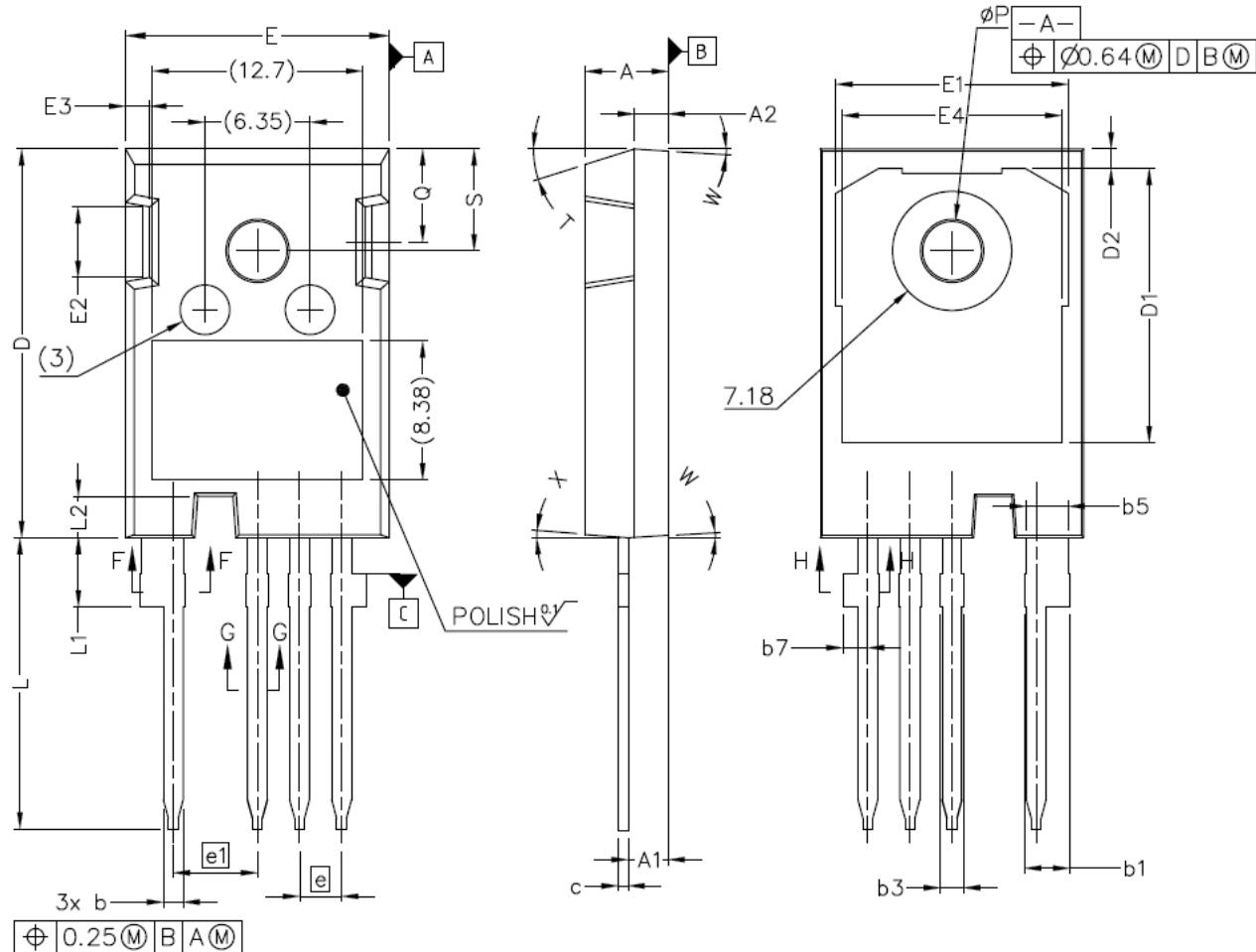
**Transient Thermal Impedance (Junction to Case)**  
 $Z_{th(J-C)} = f(t_p)$ ,  $T_c = 25^\circ\text{C}$





## Package Dimensions

Package TO-247H-4L



SECTION "F-F", "G-G" AND "H-H"  
SCALE: NONE



## Package Dimensions

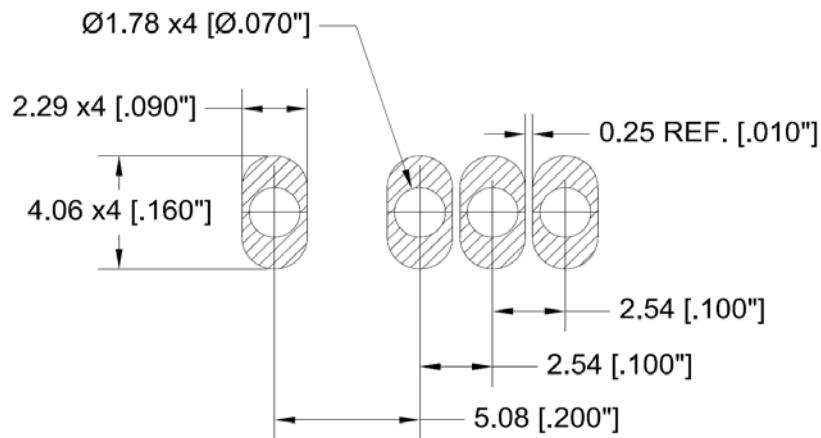
Package TO-247H-4L

NOTE :

1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT
2. DIMENSIONING & TOLERANCEING CONFIRM TO ASME Y14.5M-1994.
3. ALL DIMENSIONS ARE IN MILLIMETERS.  
ANGLES ARE IN DEGREES.
4. 'N' IS THE NUMBER OF TERMINAL POSITIONS

SYM	MILLIMETERS	
	MIN	MAX
A	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b`	1.07	1.28
b	1.07	1.33
b1	2.39	2.94
b2	2.39	2.84
b3	1.07	1.60
b4	1.07	1.50
b5	2.39	2.69
b6	2.39	2.64
b7	1.30	1.70
c`	0.55	0.65
c	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13

SYM	MILLIMETERS	
	MIN	MAX
E1	13.10	14.15
E2	3.68	5.10
E3	1.00	1.90
E4	12.38	13.43
e	2.54 BSC	
e1	5.08 BSC	
N*		4
L	17.31	17.82
L1	3.97	4.37
L2	2.35	2.65
Ø P	3.51	3.65
Q	5.49	6.00
S	6.04	6.30
T	17.5° REF.	
W	3.5° REF.	
X	4° REF.	





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